EE 130, Spring/2000 Midterm I Solutions Professor C. Hu

Problem #1

A n-type silicon sample has the energy band diagram shown below.



Qualitatively sketch the items on the following linear-linear axes: (5 points each)







Problem #2

Shallow n+p junctions are often found in state-of-the-art processes. The following is a simplified process. You may assume infinite selectivity and 100% step coverage in this process. Please fill in the missing steps and answer the questions.

-Start with a p-type silicon wafer.



Fill in the next processing step(s): (2pts)

Lithography module = (i) spin on resist, (ii) stepper exposure, (iii) develop pattern

-Ion Implant



-If the junction depth is to be kept as small as possible, which ion species would you use to make a p-n junction? List three reasons to support your answer (4pts)

Arsenic: (1) donor ion (Group IV), (2) reduced Rp and delta Rp, (3) reduced diffusivity

-Strip photoresist. RTA until the junction depth reaches 0.06um.

Paying attention to the relative dimensions, sketch the p-n junction profile inside the silicon sample shown below. (3pts)

In the accompanying axes, qualitatively draw the Na and Nd profiles along the p-n junction and indicate the position of the metallurgical junction. Assume that the implanted peak is at the Si-SiO2 interface (3pts)



-Deposit 4000A oxide as a passivation layer. *If you wanted to deposit oxide at the lowest possible temperature, what process technology would you use? (2pts)* PECVD

-*Fill in the next processing step(s): (1pt)* Lithography module

-Dry etch a contact hole over the center of the n-region.

-Strip photoresist. Deposit 4000A aluminum. *What process technology would you use to deposit aluminum? (2pts)* Sputter

-Fill in the next processing step(s): (1pt) Lithography module

-Etch a very fine (i.e. thin) aluminum line. What processing technology would you use? (2pts) Dry Etch What chemial(s) are involved? (2ts) To remove Al, use plasmas containing Cl

-Remove photoresist



Problem #3

Consider a silicon p-n junction with doping levels $Na = 10^{15} \text{cm}^{-3}$ and $Nd = 3.5 \times 10^{15} \text{cm}^{-3}$.

a) Calculate the ration of Xn to Wdep. (5pts) eqtn1: Xn+Xp = Wdep eqtn2: Xn*Nd = Xp*Na Therefore, Xp = Np/Na * Xn Plug Xp into eqtn1 to get Xn*(1+Nd/Na) = Wdep Xn/Wdep = Na/(Nd+Na) = 10^15/(4.5*10^15) = .22

b) What is the built-voltage PHIbi? (5pts) PHIbi=K*T/q*ln(Na*Nd/Ni^2) =(.026)*ln(10^15*3.5x10^15/10^20) =.63 V

c) Calculate how much of PHIbi exists on the N-side. (5pts)
(i) PHIn/PHIp = 1/2*Emax*Xn/(1/2*Emax*Xp) Therefore, PHIp = Xp/Xn * PHIn
(ii) PHIbi = PHIn+PHIp = PHIn + Xp/Xn *PHIn PHIn/PHIbi = (1 + Xp/Xn)^-1
(iii) Xp*Na = Xn*Nd PHIn/PHIbi = (!+ Nd/Na)^-1 = (1+3.5)^-1 = 1/4.5 = .22
*NOTE that this is the same expression as in part a!

d) Under a 2V reverse bias, the donor ion charge on the N-side of the depletion region is 10⁻⁶ C/cm². What is the acceptor ion charge on the P-side? (5pts)
(i) Qn-side = q*Nd*Xn = q*Na*Xp = |Qp-side| *charge neutrality Therefore, Qp-side = -10⁻⁶ C/cm²

Problem #4

The parameters shown in the figure below are known.



Write down the expressions and numerical answers for the following items:

(3pts) a) Potential barrier across the depletion region PHI = PHIbi-Va = $(K*T/q * \ln(10^{19}*10^{15}/Ni^{2}))$ -.5 = .34V

(2pts) b) Depletion width Wdep = $(2*Esi*(PHIi-Va)/(q*N))^{1/2} = (2(11.7)(8.85E-14)(.34)/((1.6E-19)(10^{15})))^{1/2} = 6um$

 $(3pts) c) Np' (0p) and Pn' (0n) \\ Np' = Np0*(e^{(q*Va/(K*T))-1)} ~ Ni^2/Na * e^{(q*Va/(K*T))} = 10^{20}/10^{15} * e^{.5}/.026 = 2.3*10^{13}/cm^{3} \\ Pn' = Pn0*(e^{(q*Va/(K*T))-1)} ~ Ni^2/Na * e^{(q*Va/(K*T))} = 10^{20}/10^{15} * e^{.5}/.026 = 2.3*10^{13}/cm^{3} \\ (10^{10}) ~ Ni^2/Na * e^{(q*Va/(K*T))} = 10^{20}/10^{15} * e^{.5}/.026 = 2.3*10^{13}/cm^{3} \\ (10^{10}) ~ Ni^2/Na * e^{(q*Va/(K*T))} = 10^{20}/10^{15} * e^{.5}/.026 = 2.3*10^{13}/cm^{3} \\ (10^{10}) ~ Ni^2/Na * e^{(q*Va/(K*T))} = 10^{20}/10^{15} * e^{.5}/.026 = 2.3*10^{13}/cm^{3} \\ (10^{10}) ~ Ni^2/Na * e^{(q*Va/(K*T))} = 10^{20}/10^{15} * e^{.5}/.026 = 2.3*10^{13}/cm^{3} \\ (10^{10}) ~ Ni^2/Na * e^{(q*Va/(K*T))} = 10^{20}/10^{15} * e^{.5}/.026 = 2.3*10^{13}/cm^{3} \\ (10^{10}) ~ Ni^2/Na * e^{.5}/(a^{10}) = 10^{10}/10^{15} * e^{.5}/.026 = 2.3*10^{13}/cm^{3} \\ (10^{10}) ~ Ni^2/Na * e^{.5}/(a^{10}) = 10^{10}/10^{15} * e^{.5}/.026 = 2.3*10^{13}/cm^{3} \\ (10^{10}) ~ Ni^2/Na * e^{.5}/(a^{10}) = 10^{10}/10^{15} * e^{.5}/.026 = 2.3*10^{13}/cm^{3} \\ (10^{10}) ~ Ni^2/Na * e^{.5}/(a^{10}) = 10^{10}/10^{15} * e^{.5}/.026 = 2.3*10^{13}/cm^{3} \\ (10^{10}) ~ Ni^2/Na * e^{.5}/(a^{10}) = 10^{10}/10^{15} * e^{.5}/.026 = 2.3*10^{13}/cm^{3} \\ (10^{10}) ~ Ni^2/Na * e^{.5}/(a^{10}) = 10^{10}/10^{15} * e^{.5}/(a^{10}) = 10^{10}/10^{15} \\ (10^{10}) ~ Ni^2/Na * e^{.5}/(a^{10}) = 10^{10}/10^{15} * e^{.5}/(a^{10}) = 10^{10}/10^{15} \\ (10^{10}) ~ Ni^2/Na * e^{.5}/(a^{10}) = 10^{10}/10^{15} \\ (10^{10}) ~ Ni^2/N$

(3pts) d) Pp'(0p) and Nn'(0n) Pp' = Np' = 2.3*10^13/cm^3 $Nn' = Pn' = 2.3 * 10^{9}/cm^{3}$

(3pts) e) Itotal (i) Itotal ~ downloaded by current in p-side = $-A^*q^*Dn^*Np0^*e^{(q^*Va/(K^*T))}/Ln$ (ii) $Dn > K^{T/q} * Un = .026*1400 = 36.4 cm^{2/s}$ $Ln = (Dn*TAUn)^{.5} = .0134cm$ (iii) Therefore, $Itotal = -[(10^{-4}cm^{2})^{*}(1.6E-19)^{*}(36.4)^{*}(10^{5})^{*}e^{(.5/.026)}]/.0134 = -.98uA$ (iv) verify: check the hole component term: $|Ih| = A^{*}q^{*}Dp^{*}Pinfinity^{*}e^{(q^{*}Va/(K^{*}T))}/Lp$ $Lp = (Dp*TAUp)^{.5} = 5E-4cm$ Therefore, $|\text{Ih}| = [(10^{-4})*(1.6E-19)*(2.6)*(10)*e^{(.5/.026)}]/5E-4 = 1.9E-10A << |\text{Ie}|$ (3pts) f) Junction depletion capacitance Cj $C_i = E_si^*A/Wdep = (11.7)^*(8.85E-14)^*(10^-4)/(.6E-4) = 1.73pF$ (3pts) g) Junction diffusion capacitance Cdiff Cdiff = Itotal*TAUe/(l*c*T/q) = 188pF(3pts) h) What is the total charge Q in the excess carrier distribution? Qtotal = Itotal*TAUe = total charge is dominated by e- injection into p-side = $(-.98uA)*(5usec) = -4.9*10^{-12C}$ (3pts) i) What is the total rate of recombination? R = rate of recombination = $Qtotal/(q*TAUe) = 4.9*10^{-12}/((1.6E-19)*(5E-6)) = 6.13*10^{12}/sec$ (4pts) k) If the capacitance of this diode were 5pF at a 2V reverse bias and 10pF at 0 bias, how should Na be changed? We still have a N+P diode; depletion cap. dominates in this region. $5pF = Esi*A/Wdep = Esi*A/(2*Esi*(PHIbi+2)/(q*N))^{.5}$ AND $10pF = Esi*A/(2*Esi*PHIbi/(q*N))^{.5}$ $5pF/10pF = 1/2 = PHIbi^{5}/(PHIbi+2)^{5}$ 1/4 = PHIbi/(PHIbi+2)PHIbi+2 = 4*PHIbi $PHIbi = 2/3 = .67V = K*T/q*ln(Na*Nd/Ni^2)$ Therefore, $Na = 1.55 \times 10^{12} cm^{-3}$

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